

<b>Notice of References Cited</b>	Application/Control No. 10/658,272	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Laura S. Weiner	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,223,353	06-1993	Ohsawa et al.	429/307
*	C	US-6,787,269	09-2004	Sekino et al.	429/330
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	K	US-			
	L	US-			
	M	US-			

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	N	JP 7-192756	07-1995	Japan	Suemori et al.	
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NON-PATENT DOCUMENTS

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	U	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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